

# gDDR3 SDRAM Graphics Addendum

## MT41J256M16 - 32 Meg x 16 x 8 Banks

#### **Features**

- $V_{DD} = V_{DDQ} = +1.5V (1.425-1.575V)$   $V_{DD} = V_{DDQ} = +1.35V (1.283-1.45V)$  capable at down clocked speeds
- Differential bidirectional data strobe
- 8*n*-bit prefetch architecture
- Differential clock inputs (CK, CK#)
- 8 internal banks
- Nominal and dynamic on-die termination (ODT) for data, strobe, and mask signals
- Programmable CAS READ latency (CL)
- Posted CAS additive latency (AL): 0, CL 1, CL 2
- Programmable CAS WRITE latency (CWL)
- Fixed burst length (BL) of 8 and burst chop (BC) of 4 (via the mode register set [MRS])
- Selectable BC4 or BL8 on-the-fly (OTF)
- · Self refresh mode
- T<sub>C</sub> of 0°C to 115°C
  - 64ms, 8192 cycle refresh at 0°C to 85°C
  - 32ms at 85°C to 115°C

- Self refresh temperature (SRT)
- Automatic self refresh (ASR)
- Write leveling
- Multipurpose register
- · Output driver calibration

Options	Marking
• Configuration	_
- 256 Meg x 16	256M16
• FBGA package (Pb-free) – x16	
<ul><li>96-ball (7.5mm x 13.5mm)</li></ul>	LY
• Timing – cycle time	
- 1.0ns @ CL = 14 (gDDR3-2000)	-091G
Operating temperature	
– Commercial (0°C ≤ $T_C$ ≤ 115°C)	None
• Revision	:N

Note: 1. For complete device functionality and specifications, refer to the standard 4Gb DDR3 SDRAM data sheet found at www.micron.com. The information in this data sheet supersedes the standard data sheet.

**Table 1: Key Timing Parameters** 

Speed Grade	Data Rate (MT/s)	Target <sup>t</sup> RCD- <sup>t</sup> RP-CL	<sup>t</sup> RCD (ns)	<sup>t</sup> RP (ns)	CL (ns)
	2200 <sup>1</sup>	15-15-15	13.65	13.65	13.65
-091G	2000 <sup>2</sup>	14-14-14	14	14	14
-091G	1800 <sup>2</sup>	13-13-13	14.3	14.3	14.3
	1600 <sup>2</sup>	11-11-11	13.75	13.75	13.75

1. Requires  $V_{DD} = V_{DDQ} = +1.5V_{NOM}$ 

2.  $V_{DD} = V_{DDO} = +1.35V_{NOM}$  capable

#### **Table 2: Addressing**

Parameter	256 Meg x 16
Configuration	32 Meg x 16 x 8 banks
Refresh count	8K
Row addressing	32K (A[14:0])
Bank addressing	8 (BA[2:0])
Column addressing	1K (A[9:0])



# 4Gb: x16 gDDR3 SDRAM Graphics Addendum Features

#### **Table 3: Part Number Cross Reference**

Micron Part Number	FBGA Code
MT41J256M16LY-091G:N	D9SMP

### **FBGA Part Marking Decoder**

Due to space limitations, FBGA-packaged components have an abbreviated part marking that is different from the part number. Micron's FBGA part marking decoder is available at <a href="https://www.micron.com/decoder">www.micron.com/decoder</a>.



# **Ball Assignments**

Figure 1: 96-Ball FBGA - x16 (Top View)

	1	2	3	4	5	6	7	8	9
	_		_				_	_	
Α	V <sub>DDQ</sub>	DQ13	DQ15				DQ12	$V_{DDQ}$	V <sub>SS</sub>
В	V <sub>SSQ</sub>	$\bigvee_{V_{DD}}$	$\bigvee_{V_{SS}}$				UDQS#	DQ14	
С	V <sub>DDQ</sub>	DQ11					UDQS	DQ10	V <sub>SSQ</sub> V <sub>DDQ</sub> V <sub>DDQ</sub>
D	V <sub>SSQ</sub>	$\bigvee_{V_{DDQ}}$	DQ9				DQ8	$\bigvee_{V_{SSQ}}$	V <sub>DD</sub>
E	Vss	$\bigvee_{V_{SSQ}}$	UDM DQ0				LDM	$\bigcup_{V_{SSQ}}$	
F	V <sub>DDQ</sub>	DQ2	LDQS				DQ1	DQ3	V <sub>DDQ</sub>
G	V <sub>SSQ</sub>	DQ6	LDQS#				$\bigvee_{V_{DD}}$	$\bigvee_{V_{SS}}$	V <sub>SSQ</sub>
Н	V <sub>REFDQ</sub>	$\bigvee_{V_{DDQ}}$	DQ4				DQ7	DQ5	V <sub>DDQ</sub>
J	NC NC	$\bigvee_{V_{SS}}$	RAS#				○ CK	$\bigcup_{V_{SS}}$	O NC
K	ODT	$\bigcup_{V_{DD}}$	CAS#				CK#	$\bigvee_{V_{DD}}$	CKE
L	NC NC	CS#	WE#				A10/AP	ZQ	O NC
М	V <sub>SS</sub>	BA0	BA2				ONC NC	V <sub>REFCA</sub>	$\bigcup_{V_{SS}}$
N	$V_{DD}$	A3	A0				A12/BC#	O BA1	$\bigcup_{V_DD}$
Р	V <sub>SS</sub>	A3 A5					A1		Vss
R	V <sub>SS</sub> V <sub>DD</sub> V <sub>SS</sub> V <sub>DD</sub> V <sub>DD</sub>	A3	A2				A11	A4 A6	$\bigcup_{V_DD}$
Т	V <sub>SS</sub>	RESET#	NC				NC	A8	VDDQ NC CKE NC VSSS VDD VSSS VDD VSSS

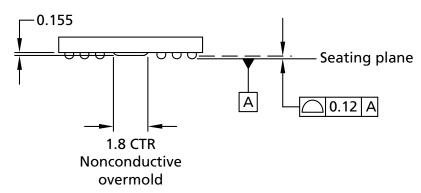
Notes: 1. Ball descriptions are listed in the main 4Gb DDR3 data sheet.

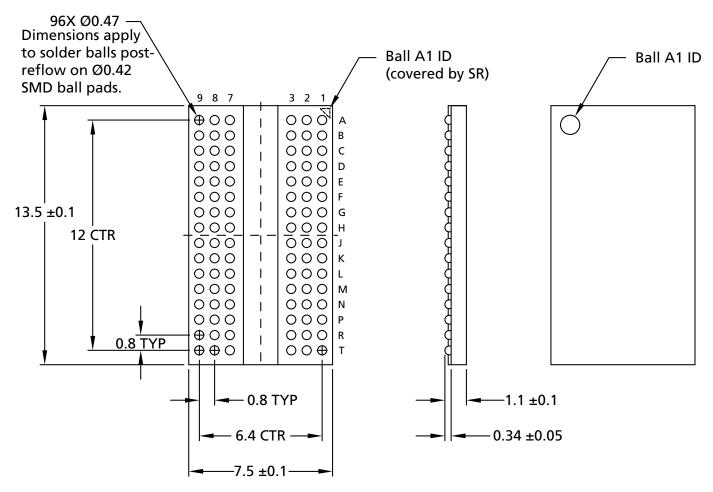
2. A comma separates the configuration; a slash defines a selectable function. Example D7 = NF, NF/TDQS# is selectable between NF or TDQS# via MRS.



# **Package Dimensions**

Figure 2: 96-Ball FBGA - x16 (LY)





Note: 1. All dimensions are in millimeters.



### **Electrical Specifications**

#### **Table 4: DC Electrical Characteristics and Operating Conditions**

All voltages are referenced to V<sub>ss</sub>

Parameter/Condition	Symbol	Min	Nom	Max	Unit	Notes
Supply voltage	V <sub>DD</sub>	1.425	1.5	1.575	V	1, 2, 3
I/O supply voltage	$V_{DDQ}$	1.425	1.5	1.575	V	1, 2, 3
Supply voltage	V <sub>DD</sub>	1.283	1.35	1.45	V	1, 2, 4
I/O supply voltage	$V_{DDQ}$	1.283	1.35	1.45	V	1, 2, 4

- Notes: 1.  $V_{DD}$  and  $V_{DDQ}$  must track one another.  $V_{DDQ}$  must be  $\leq V_{DD}$ .  $V_{SS} = V_{SSQ}$ .
  - 2. V<sub>DD</sub> and V<sub>DDO</sub> may include AC noise of ±50mV (250 kHz to 20 MHz) in addition to the DC (0 Hz to 250 kHz) specifications.  $V_{DD}$  and  $V_{DDO}$  must be at same level for valid AC timing parameters.
  - 3. Valid with all speed bins.
  - 4. Not for use with -093 speed bin.

#### **Table 5: Input/Output Capacitance**

Note 1 applies to the entire table

Capacitance		gDDR:	3-1600	gDDR3	3-1800	gDDR:	3-2000	gDDR:	3-2200		Note
Parameters	Symbol	Min	Max	Min	Max	Min	Max	Min	Max	Unit	s
CK and CK#	C <sub>CK</sub>	0.8	1.4	0.8	1.3	0.8	1.3	0.8	1.3	pF	
ΔC: CK to CK#	C <sub>DCK</sub>	0	0.15	0	0.15	0	0.15	0	0.15	pF	
Single-end I/O: DQ, DM	C <sub>IO</sub>	1.5	2.3	1.5	2.2	1.5	2.1	1.5	2.1	pF	2
Differential I/O: DQS, DQS#, TDQS, TDQS#	C <sub>IO</sub>	1.5	2.3	1.5	2.2	1.5	2.1	1.5	2.1	pF	3
ΔC: DQS to DQS#, TDQS, TDQS#	C <sub>DDQS</sub>	0	0.15	0	0.15	0	0.15	0	0.15	pF	3
ΔC: DQ to DQS	C <sub>DIO</sub>	-0.5	0.3	-0.5	0.3	-0.5	0.3	-0.5	0.3	pF	4
Inputs (CTRL, CMD, ADDR)	C <sub>I</sub>	0.75	1.3	0.75	1.2	0.75	1.2	0.75	1.2	pF	5
ΔC: CTRL to CK	C <sub>DI_CTRL</sub>	-0.4	0.2	-0.4	0.2	-0.4	0.2	-0.4	0.2	pF	6
ΔC: CMD_ADDR to CK	C <sub>DI_CMD_AD</sub>	-0.4	0.4	-0.4	0.4	-0.4	0.4	-0.4	0.4	pF	7
ZQ pin capacitance	C <sub>zO</sub>	-	3.0	_	3.0	-	3.0	_	3.0	pF	
Reset pin capacitance	C <sub>RE</sub>	-	3.0	-	3.0	-	3.0	_	3.0	pF	

Notes:

- 1.  $V_{DD} = +1.5V \pm 0.075$  mV,  $V_{DDQ} = V_{DD}$ ,  $V_{REF} = V_{SS}$ , f = 100 MHz,  $T_{C} = 25$  °C.  $V_{OUT(DC)} = 0.5 \times 10^{-5}$  $V_{DDO}$ ,  $V_{OUT} = 0.1V$  (peak-to-peak).
- 2. DM input is grouped with I/O pins, reflecting the fact that they are matched in loading.
- 3. Includes TDQS, TDQS#. C<sub>DDQS</sub> is for DQS vs. DQS# and TDQS vs. TDQS# separately.
- 4.  $C_{DIO} = C_{IO(DQ)} 0.5 \times (C_{IO(DQS)} + C_{IO(DQS\#)}).$
- 5. Excludes CK, CK#; CTRL = ODT, CS#, and CKE; CMD = RAS#, CAS#, and WE#; ADDR = A[n:0], BA[2:0].
- 6.  $C_{DI\_CTRL} = C_{I(CTRL)} 0.5 \times (C_{CK(CK)} + C_{CK(CK\#)}).$
- 7.  $C_{DI\_CMD\_ADDR} = C_{I(CMD\_ADDR)} 0.5 \times (C_{CK(CK)} + C_{CK(CK\#)})$ .

## **Electrical Characteristics – IDD Specifications**

 $I_{\mathrm{DD}}$  values are for full operating range of voltage and temperature unless otherwise noted.

Table 6: I<sub>DD</sub> Maximum Limits - Die Rev. N

Speed Bin						
I <sub>DD</sub>	gDDR3-1600	gDDR3-1800	gDDR3-2000	gDDR3-2200	Units	Notes
I <sub>DD0</sub>	66	73	82	82	mA	1, 2
I <sub>DD1</sub>	87	91	96	96	mA	1, 2
I <sub>DD2P0</sub> (slow)	18	18	18	18	mA	1, 2
I <sub>DD2P1</sub> (fast)	32	35	43	43	mA	1, 2
I <sub>DD2Q</sub>	32	30	37	37	mA	1, 2
I <sub>DD2N</sub>	32	35	37	37	mA	1, 2
I <sub>DD2NT</sub>	42	45	49	49	mA	1, 2
I <sub>DD3P</sub>	38	41	44	44	mA	1, 2
I <sub>DD3N</sub>	47	49	52	52	mA	1, 2
I <sub>DD4R</sub>	235	252	285	285	mA	1, 2
I <sub>DD4W</sub>	171	190	200	200	mA	1, 2
I <sub>DD5B</sub>	235	242	250	250	mA	1, 2
I <sub>DD6</sub>	20	20	20	20	mA	1, 2, 3
I <sub>DD6ET</sub>	25	25	25	25	mA	2, 4
I <sub>DD7</sub>	243	274	305	305	mA	1, 2
I <sub>DD8</sub>	I <sub>DD2P0</sub> + 2mA	mA	1, 2			

- Notes: 1.  $T_C = 85$ °C; SRT and ASR are disabled.
  - 2. Enabling ASR could increase  $I_{DDx}$  by up to an additional 2mA.
  - 3. Restricted to  $T_C$  (MAX) = 85°C.
  - 4.  $T_C = 85$ °C; ASR and ODT are disabled; SRT is enabled.
  - 5. The I<sub>DD</sub> values must be derated (increased) on IT-option devices when operated outside of the range  $0^{\circ}C \le T_C \le 85^{\circ}C$ :
    - When  $T_C < 0$ °C:  $I_{DD2P}$  and  $I_{DD3P}$  must be derated by 4%;  $I_{DD4R}$  and  $I_{DD5W}$  must be derated by 2%; and  $I_{DD6}$  and  $I_{DD7}$  must be derated by 7%.
    - When  $T_C > 85$ °C:  $I_{DD0}$ ,  $I_{DD1}$ ,  $I_{DD2N}$ ,  $I_{DD2NT}$ ,  $I_{DD2Q}$ ,  $I_{DD3N}$ ,  $I_{DD3P}$ ,  $I_{DD4R}$ ,  $I_{DD4W}$ , and  $I_{DD5W}$  must be derated by 2%; I<sub>DD2Px</sub> must be derated by 30%.



### **Speed Bin Tables**

#### Table 7: gDDR3-1600 Speed Bins

gDDR3-1600 Speed Bin			-12	25 <b>G</b>		
CL- <sup>t</sup> RCD- <sup>t</sup> RP			11-1	1-11		
Parameter		Symbol	Min	Max	Unit	Notes
ACTIVATE to internal READ	or WRITE delay time	<sup>t</sup> RCD	13.75	-	ns	
PRECHARGE command peri	od	<sup>t</sup> RP	13.75	_	ns	
ACTIVATE-to-ACTIVATE or F	REFRESH command period	<sup>t</sup> RC	48.75	_	ns	
ACTIVATE-to-PRECHARGE of	ommand period	<sup>t</sup> RAS	35	9 x <sup>t</sup> REF	ns	1
CL = 5	CWL = 5	<sup>t</sup> CK (AVG)	3.0	3.3	ns	2
	CWL = 6, 7, 8	<sup>t</sup> CK (AVG)	Rese	rved	ns	3
CL = 6	CWL = 5	<sup>t</sup> CK (AVG)	2.5	3.3	ns	2
	CWL = 6, 7, 8	<sup>t</sup> CK (AVG)	Rese	rved	ns	3
CL = 7	CWL = 5	<sup>t</sup> CK (AVG)	Rese	rved	ns	3
	CWL = 6	<sup>t</sup> CK (AVG)	1.875	<2.5	ns	2
	CWL = 7, 8	<sup>t</sup> CK (AVG)	Rese	rved	ns	3
CL = 8	CWL = 5	<sup>t</sup> CK (AVG)	Rese	rved	ns	3
	CWL = 6	<sup>t</sup> CK (AVG)	1.875	<2.5	ns	2
	CWL = 7, 8	<sup>t</sup> CK (AVG)	Rese	rved	ns	3
CL = 9	CWL = 5, 6	<sup>t</sup> CK (AVG)	Rese	rved	ns	3
	CWL = 7	<sup>t</sup> CK (AVG)	1.5	<1.875	ns	2
	CWL = 8	<sup>t</sup> CK (AVG)	Rese	rved	ns	3
CL = 10	CWL = 5, 6	<sup>t</sup> CK (AVG)	Rese	rved	ns	3
	CWL = 7	<sup>t</sup> CK (AVG)	1.5	<1.875	ns	2
	CWL = 8	<sup>t</sup> CK (AVG)	Rese	rved	ns	3
CL = 11	CWL = 5, 6, 7	<sup>t</sup> CK (AVG)	Rese	rved	ns	3
	CWL = 8	<sup>t</sup> CK (AVG)	1.25	<1.5	ns	2
Supported CL settings		•	5, 6, 7, 8,	9, 10, 11	СК	
Supported CWL settings			5, 6,	7, 8	СК	

- Notes: 1. <sup>t</sup>REFI depends on T<sub>OPER</sub>.
  - 2. The CL and CWL settings result in <sup>t</sup>CK requirements. When making a selection of <sup>t</sup>CK, both CL and CWL requirement settings need to be fulfilled.
  - 3. Reserved settings are not allowed.

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Table 8: gDDR3-1800 Speed Bins

gDDR3-1800 Speed Bin			-10	)7G		
CL- <sup>t</sup> RCD- <sup>t</sup> RP			13-1	13-13		
Parameter		Symbol	Min	Max	Unit	Notes
ACTIVATE to internal READ of	or WRITE delay time	<sup>t</sup> RCD	14.3	-	ns	
PRECHARGE command perio	PRECHARGE command period		14.3	-	ns	
ACTIVATE-to-ACTIVATE or RE	FRESH command period	<sup>t</sup> RC	48.91	-	ns	
ACTIVATE-to-PRECHARGE co	mmand period	<sup>t</sup> RAS	35	9 x <sup>t</sup> REFI	ns	1
CL = 5	CWL = 5	<sup>t</sup> CK (AVG)	3.0	3.3	ns	3
	CWL = 6, 7, 8, 9	<sup>t</sup> CK (AVG)	Rese	erved	ns	3
CL = 6	CWL = 5	<sup>t</sup> CK (AVG)	2.5	3.3	ns	2
	CWL = 6, 7, 8, 9	<sup>t</sup> CK (AVG)	Rese	erved	ns	3
CL = 7	CWL = 5, 7, 8, 9	<sup>t</sup> CK (AVG)	2.5	3.3	ns	2
	CWL = 6	<sup>t</sup> CK (AVG)	Rese	erved	ns	3
CL = 8	CWL = 5, 7, 8, 9	<sup>t</sup> CK (AVG)	Rese	erved	ns	3
	CWL = 6	<sup>t</sup> CK (AVG)	1.875	<2.5	ns	2
CL = 9	CWL = 5, 6, 8, 9	tCK (AVG)	Rese	erved	ns	3
	CWL = 7	tCK (AVG)	1.875	<2.5	ns	3
CL = 10	CWL = 5, 6, 9	tCK (AVG)	Rese	erved	ns	3
	CWL = 7	tCK (AVG)	1.5	<1.875	ns	2
	CWL = 8	tCK (AVG)	Rese	erved	ns	3
CL = 11	CWL = 5, 6, 7	tCK (AVG)	Rese	erved	ns	3
	CWL = 8	tCK (AVG)	1.5	<1.875	ns	2
	CWL = 9	tCK (AVG)	Rese	erved	ns	3
CL - 12	CWL = 5, 6, 7, 8	tCK (AVG)	Rese	erved	ns	3
	CWL = 9	tCK (AVG)	Rese	erved	ns	3
CL = 13	CWL = 5, 6, 7, 8	tCK (AVG)	Rese	erved	ns	3
	CWL = 9	tCK (AVG)	1.1	<1.25	ns	2
Supported CL settings		•	5, 6, 7, 8, 9	9, 10, 11, 13	СК	
Supported CWL settings			5, 6,	7, 8, 9	CK	

- Notes: 1. <sup>t</sup>REFI depends on T<sub>OPER</sub>.
  - 2. The CL and CWL settings result in <sup>t</sup>CK requirements. When making a selection of <sup>t</sup>CK, both CL and CWL requirement settings need to be fulfilled.
  - 3. Reserved settings are not allowed.

# 4Gb: x16 gDDR3 SDRAM Graphics Addendum Speed Bin Tables

Table 9: gDDR3-2000 Speed Bins

gDDR3-2000 Speed Bin			-0	93G		
CL- <sup>t</sup> RCD- <sup>t</sup> RP			14-	14-14		
Parameter		Symbol	Min	Мах	Unit	Notes
ACTIVATE to internal READ or	WRITE delay time	<sup>t</sup> RCD	14	-	ns	
PRECHARGE command period		<sup>t</sup> RP	14	_	ns	
ACTIVATE-to-ACTIVATE or REF	RESH command period	<sup>t</sup> RC	50	_	ns	
ACTIVATE-to-PRECHARGE com	mand period	<sup>t</sup> RAS	36	9 x <sup>t</sup> REFI	ns	1
CL = 5	CWL = 5	<sup>t</sup> CK (AVG)	3.0	3.3	ns	2
	CWL = 6, 7, 8, 9	<sup>t</sup> CK (AVG)	Res	served	ns	3
CL = 6	CWL = 5	<sup>t</sup> CK (AVG)	2.5	3.3	ns	2
	CWL = 6, 7, 8, 9	<sup>t</sup> CK (AVG)	Res	served	ns	3
CL = 7	CWL = 5, 7, 8, 9	<sup>t</sup> CK (AVG)	2.5	3.3	ns	3
	CWL = 6	<sup>t</sup> CK (AVG)	Res	served	ns	3
CL = 8	CWL = 5, 7, 8, 9	<sup>t</sup> CK (AVG)	Res	erved	ns	3
	CWL = 6	<sup>t</sup> CK (AVG)	1.875	<2.5	ns	2
CL = 9	CWL = 5, 6, 8, 9	<sup>t</sup> CK (AVG)	Res	served	ns	3
	CWL = 7	<sup>t</sup> CK (AVG)	1.875	<2.5	ns	3
CL = 10	CWL = 5, 6, 9	<sup>t</sup> CK (AVG)	Res	served	ns	3
	CWL = 7	<sup>t</sup> CK (AVG)	1.5	<1.875	ns	2
	CWL = 8	<sup>t</sup> CK (AVG)	Res	served	ns	3
CL = 11	CWL = 5, 6, 7	<sup>t</sup> CK (AVG)	Res	erved	ns	3
	CWL = 8	tCK (AVG)	1.5	<1.875	ns	3
	CWL = 9	tCK (AVG)	Res	served	ns	3
CL - 12	CWL = 5, 6, 7, 8	tCK (AVG)	Res	erved	ns	3
	CWL = 9	tCK (AVG)	Res	erved	ns	3
CL = 13	CWL = 5, 6, 7, 8	<sup>t</sup> CK (AVG)	Res	erved	ns	3
	CWL = 9	<sup>t</sup> CK (AVG)	1.1	<1.25	ns	2
CL = 14	CWL = 5, 6, 7, 8, 9	<sup>t</sup> CK (AVG)	1	<1.1	ns	2
	CWL = 10					
Supported CL settings	<u>'</u>		5, 6, 7, 8, 9, 10, 11, 13, 14		CK	
Supported CWL settings			5, 6, 7	, 8, 9, 10	CK	

- Notes: 1. <sup>t</sup>REFI depends on T<sub>OPER</sub>.
  - 2. The CL and CWL settings result in <sup>t</sup>CK requirements. When making a selection of <sup>t</sup>CK, both CL and CWL requirement settings need to be fulfilled.
  - 3. Reserved settings are not allowed.

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Table 10: gDDR3-2200 Speed Bins

gDDR3-2200 Speed Bin	1		-0	91G		
CL- <sup>t</sup> RCD- <sup>t</sup> RP			15-	15-15		
Parameter		Symbol	Min	Мах	Unit	Notes
ACTIVATE to internal REA	AD or WRITE delay time	<sup>t</sup> RCD	13.65	_	ns	
PRECHARGE command pe	eriod	<sup>t</sup> RP	13.65	_	ns	
ACTIVATE-to-ACTIVATE or REFRESH command period		<sup>t</sup> RC	46.13	_	ns	
ACTIVATE-to-PRECHARGE command period		<sup>t</sup> RAS	33	9 x <sup>t</sup> REFI	ns	1
CL = 5	CWL = 5	<sup>t</sup> CK (AVG)	3.0	3.3	ns	2
	CWL = 6, 7, 8, 9	<sup>t</sup> CK (AVG)	Res	served	ns	3
CL = 6	CWL = 5	<sup>t</sup> CK (AVG)	2.5	3.3	ns	2
	CWL = 6, 7, 8, 9	<sup>t</sup> CK (AVG)	Res	served	ns	3
CL = 7	CWL = 5, 7, 8, 9	<sup>t</sup> CK (AVG)	2.5	3.3	ns	2
	CWL = 6	<sup>t</sup> CK (AVG)	Res	served	ns	3
CL = 8	CWL = 5, 7, 8, 9	<sup>t</sup> CK (AVG)	Res	erved	ns	3
	CWL = 6	<sup>t</sup> CK (AVG)	1.875	<2.5	ns	2
CL = 9	CWL = 5, 6, 8, 9	<sup>t</sup> CK (AVG)	Res	erved	ns	3
	CWL = 7	<sup>t</sup> CK (AVG)	1.875	<2.5	ns	2
CL = 10	CWL = 5, 6, 9	<sup>t</sup> CK (AVG)	Res	erved	ns	3
	CWL = 7	<sup>t</sup> CK (AVG)	1.5	<1.875	ns	2
	CWL = 8	<sup>t</sup> CK (AVG)	Res	served	ns	3
CL = 11	CWL = 5, 6, 7	<sup>t</sup> CK (AVG)	Res	erved	ns	3
	CWL = 8	<sup>t</sup> CK (AVG)	1.5	<1.875	ns	2
	CWL = 9	<sup>t</sup> CK (AVG)	Res	served	ns	3
CL - 12	CWL = 5, 6, 7, 8	<sup>t</sup> CK (AVG)	Res	erved	ns	3
	CWL = 9	<sup>t</sup> CK (AVG)	Res	erved	ns	3
CL = 13	CWL = 5, 6, 7, 8	<sup>t</sup> CK (AVG)	Res	erved	ns	3
	CWL = 9	<sup>t</sup> CK (AVG)	1.1	<1.25	ns	2
CL = 14	CWL = 5, 6, 7, 8, 9	<sup>t</sup> CK (AVG)	1	<1.1	ns	2
	CWL = 10					
CL=15	CWL = 5, 6, 7, 8, 9, 10	<sup>t</sup> CK (AVG)	.091	<1	ns	2
	CWL = 11					
Supported CL settings			5, 6, 7, 8, 9,	10, 11, 13, 14, 15	CK	
Supported CWL settings			5, 6, 7,	3, 9, 10, 11	CK	

- Notes: 1. <sup>t</sup>REFI depends on T<sub>OPER</sub>.
  - 2. The CL and CWL settings result in <sup>t</sup>CK requirements. When making a selection of <sup>t</sup>CK, both CL and CWL requirement settings need to be fulfilled.
  - 3. Reserved settings are not allowed.



# **Electrical Characteristics and AC Operating Conditions**

#### **Table 11: Electrical Characteristics and AC Operating Conditions for Speed Extensions**

			gDDR:	3-2000	gDDR:	3-2200		
Parameter		Symbol	Min	Max	Min	Max	Unit	Notes
	Clo	ck Timing						
Clock period average:	T <sub>C</sub> = 0°C to 85°C	tCK (DLL_DIS)	8	7800	8	7800	ns	9, 42
DLL disable mode	T <sub>C</sub> = >85°C to 115°C		8	3900	8	3900	ns	42
Clock period average: DL	L enable mode	<sup>t</sup> CK (AVG)	See corre	sponding	speed bin	table for	ns	10, 11
				-	CK .			
		+511 (4) (5)	0.47		allowed	0.50		4.2
High pulse width averag		tCH (AVG)	0.47	0.53	0.47	0.53	CK	12
Low pulse width average	1	tCL (AVG)	0.47	0.53	0.47	0.53	CK	12
Clock period jitter	DLL locked	<sup>t</sup> JIT <sub>PER</sub>	-60	60	-60	60	ps	13
	DLL locking	<sup>t</sup> JIT <sub>PER</sub> ,lck	-50	50	-50	50	ps	13
Clock absolute period		tCK (ABS)		CK (AVG)			ps	
		4 (>	<u> </u>	CK (AVG) I	MAX + <sup>t</sup> JIT <sub>PER</sub> MAX			
Clock absolute high puls	e width	<sup>t</sup> CH (ABS)	0.43	_	0.43	-	tCK	14
Clark abank ta law mulaa	:	tci (ABC)	0.42		0.42		(AVG)	15
Clock absolute low pulse	wiath	<sup>t</sup> CL (ABS)	0.43	_	0.43	_	(AVG)	15
Cycle-to-cycle jitter	DLL locked	tJIT <sub>CC</sub>	1.	 20	1:	20	ps	16
System to system justice.	DLL locking	<sup>t</sup> JIT <sub>CC</sub> ,lck		00		100 p	ps	16
Cumulative error across	2 cycles	tERR2 <sub>PER</sub>	-88	88	-88		ps	17
camarative error across	3 cycles	tERR3 <sub>PER</sub>	-105	105	-105	105	ps	17
	4 cycles	tERR4 <sub>PER</sub>	-117	117	-117	117	ps	17
	5 cycles	tERR5 <sub>PER</sub>	-126	126	-126	126	ps	17
	6 cycles	tERR6 <sub>PER</sub>	-133	133	-133	133	ps	17
	7 cycles	tERR7 <sub>PER</sub>	-139	139	-139	139	ps	17
	8 cycles	tERR8 <sub>PER</sub>	-145	145	-145	145	ps	17
	9 cycles	tERR9 <sub>PER</sub>	-150	150	-150	150	ps	17
	10 cycles	tERR10 <sub>PER</sub>	-154	154	-154	154	•	17
	11 cycles	tERR11 <sub>PER</sub>	-158	158	-158	154	ps	17
	-	1					ps	
	12 cycles n = 13, 1449, 50	tERR12 <sub>PER</sub>	-161	161	-161	161	ps	17
	<sup>t</sup> ERR <i>n</i> per	EKKn <sub>PER</sub>	MIN = (1 +	i 0.68in[ <i>n</i> ] IN	PER III' × (	ps	17	
	cycles		tERRn:	<sub>ER</sub> MAX =		n[ <i>n</i> ]) ×		
					MAX			
	DQ Ir	put Timing						
Data setup time to DQS,	Base (specification)	<sup>t</sup> DS	_	_	_	_	ps	18, 19
DQS#	V <sub>REF</sub> @ 1 V/ns	(AC175)						



#### **Table 11: Electrical Characteristics and AC Operating Conditions for Speed Extensions (Continued)**

Notes 1–8 apply to the en	the table		gDDR	3-2000	gDDR	3-2200		
Parameter		Symbol	Min	Max	Min	Max	Unit	Notes
Data setup time to DQS,	Base (specification)	<sup>t</sup> DS	_	_	10	_	ps	18, 19
DQS#	V <sub>REF</sub> @ 1 V/ns	(AC150)	_	_	160	_	ps	19, 20
Data setup time to DQS, DQS#	Base (specification)@ 2 V/ns	<sup>t</sup> DS (AC135)	68	-	-	-	ps	19, 20
	V <sub>REF</sub> @ 2 V/ns		135	_	_	_		19, 20
Data hold time from	Base (specification)	<sup>t</sup> DH	70	_	70	_	ps	18, 19
DQS, DQS#	V <sub>REF</sub> @ 1 V/ns	(DC100)	120	_	120	_	ps	19, 20
Minimum data pulse wid	th	<sup>t</sup> DIPW	320	_	320	_	ps	41
	DQ Out							
DQS, DQS# to DQ skew, p	per access	<sup>t</sup> DQSQ	_	85	_	85	ps	
DQ output hold time from	m DQS, DQS#	<sup>t</sup> QH	0.38	_	0.38	_	<sup>t</sup> CK (AVG)	21
DQ Low-Z time from CK,	CK#	tLZ (DQ)	-390	195	-390	195	ps	22, 23
DQ High-Z time from CK,	CK#	<sup>t</sup> HZ (DQ)	_	195	_	195	ps	22, 23
	DQ Strob	e Input Timin	g	'				
DQS, DQS# rising to CK, CK# rising		<sup>t</sup> DQSS	-0.27	0.27	-0.27	0.27	CK	25
DQS, DQS# differential in	QS# differential input low pulse width		0.45	0.55	0.45	0.55	CK	
DQS, DQS# differential in	put high pulse width	<sup>t</sup> DQSH	0.45	0.55	0.45	0.55	CK	
DQS, DQS# falling setup	to CK, CK# rising	<sup>t</sup> DSS	0.18	_	0.18	_	CK	25
DQS, DQS# falling hold fi	rom CK, CK# rising	<sup>t</sup> DSH	0.18	-	0.18	_	CK	25
DQS, DQS# differential W	/RITE preamble	tWPRE	0.9	-	0.9	_	CK	
DQS, DQS# differential W	/RITE postamble	tWPST	0.3	_	0.3	_	CK	
	DQ Strobe	Output Timi	ng					
DQS, DQS# rising to/from	rising CK, CK#	<sup>t</sup> DQSCK	-195	195	-195	195	ps	23
DQS, DQS# rising to/from DLL is disabled	rising CK, CK# when	<sup>t</sup> DQSCK (DLL_DIS)	1	10	1	10	ns	26
DQS, DQS# differential o	utput high time	<sup>t</sup> QSH	0.40	_	0.40	_	CK	21
DQS, DQS# differential o	utput low time	<sup>t</sup> QSL	0.40	_	0.40	_	CK	21
DQS, DQS# Low-Z time (F	RL - 1)	<sup>t</sup> LZ (DQS)	-390	195	-391	195	ps	22, 23
DQS, DQS# High-Z time (	RL + BL/2)	<sup>t</sup> HZ (DQS)	_	195	_			22, 23
DQS, DQS# differential R	EAD preamble	<sup>t</sup> RPRE	0.9	Note 24	0.9	Note 24	CK	23, 24
DQS, DQS# differential R	EAD postamble	<sup>t</sup> RPST	0.3	Note 27	0.3	Note 27	CK	23, 27
	Command ar	nd Address Ti	ming					
DLL locking time			512	_	512	_	CK	28
CTRL, CMD, ADDR	Base (specification)	<sup>t</sup> IS	_	_	45	-	ps	29, 30
setup to CK,CK#	V <sub>REF</sub> @ 1 V/ns	(AC175)	-	_	220	_	ps	20, 30



#### **Table 11: Electrical Characteristics and AC Operating Conditions for Speed Extensions (Continued)**

Base (specification)  V <sub>REF</sub> @ 1 V/ns  DDR pulse width	t S (AC150) t S (AC135) t S (AC125) t H (DC100)	Min  -  -  65  200  150  275	- - - -	Min 170 320 -	- - -	ps ps ps	29, 30 20, 30
V <sub>REF</sub> @ 1 V/ns Base (specification) V <sub>REF</sub> @ 1 V/ns Base (specification) V <sub>REF</sub> @ 1 V/ns Base (specification) V <sub>REF</sub> @ 1 V/ns	(AC150)  t S (AC135)  t S (AC125)  t H	65 200 150	-	320	_	ps ps	
Base (specification)  V <sub>REF</sub> @ 1 V/ns  Base (specification)  V <sub>REF</sub> @ 1 V/ns  Base (specification)  V <sub>REF</sub> @ 1 V/ns	<sup>t</sup> IS (AC135) <sup>t</sup> IS (AC125) <sup>t</sup> IH	65 200 150	-	_	_	ps	20, 30
V <sub>REF</sub> @ 1 V/ns Base (specification) V <sub>REF</sub> @ 1 V/ns Base (specification) V <sub>REF</sub> @ 1 V/ns	(AC135)  tIS (AC125)  tIH	200	_	-		•	
Base (specification)  V <sub>REF</sub> @ 1 V/ns  Base (specification)  V <sub>REF</sub> @ 1 V/ns	<sup>t</sup> IS (AC125) <sup>t</sup> IH	150		_	_		
V <sub>REF</sub> @ 1 V/ns Base (specification) V <sub>REF</sub> @ 1 V/ns	(AC125)		_			ps	
Base (specification) V <sub>REF</sub> @ 1 V/ns	tIH	275		_	_	ps	
V <sub>REF</sub> @ 1 V/ns			_	-	_	ps	
1	(DC100)	100	_	120	_	ps	29, 30
NDB pulse width	(DC100)	200	_	220	_	ps	20, 30
DK puise wiatri	<sup>t</sup> IPW	620	_	560	_	ps	41
AD or WRITE delay	<sup>t</sup> RCD	See corre		-	table for	ns	31
eriod	<sup>t</sup> RP	See corre	· .	=	table for	ns	31
command period	<sup>t</sup> RAS	See corre		-	table for	ns	31, 32
ommand period	<sup>t</sup> RC	See corresponding speed bin table fo		table for	ns	31	
od	<sup>t</sup> RRD	_		_		CK	31
	<sup>t</sup> FAW	35	_	35	_	ns	31
	<sup>t</sup> WR	15	N/A	15	N/A	ns	31, 32, 33,34
	<sup>t</sup> WTR	MIN = gr			ns; MAX =	CK	31, 34
ie	<sup>t</sup> RTP	MIN = gr			ns; MAX =	CK	31, 32
delay	<sup>t</sup> CCD	N	11N = 4CK;	MAX = N	/A	CK	
overy + precharge	<sup>t</sup> DAL	MIN = WI	R + <sup>t</sup> RP/ <sup>t</sup> Ck	(AVG); N	IAX = N/A	CK	
mand cycle time	<sup>t</sup> MRD	N	1IN = 4CK;	MAX = N	/A	CK	
imand update delay	<sup>t</sup> MOD	MIN = greater of 12CK or 15ns; MAX = N/A				CK	
	<sup>t</sup> MPRR	MIN = 1CK; MAX = N/A		CK			
Calibra	tion Timing						
POWER-UP and RE- SET operation	<sup>t</sup> ZQ <sub>INIT</sub>	512	_	512	-	CK	
Normal operation	<sup>t</sup> ZQ <sub>OPER</sub>	256	_	256	_	CK	
	and or WRITE delay eriod E command period ommand period od o	AD or WRITE delay  eriod  tRP  E command period  tRAS  ommand period  tRC  tRD  od  tFAW  tWR  anal WRITE transaction and are  tRTP  delay  covery + precharge  tmand cycle time amand cycle time amand update delay  tRD  tMRD  tMPRR  TMPR  Calibration Timing  POWER-UP and RE- SET operation	AD or WRITE delay  trace is a command period  tr	AD or WRITE delay  triod  trio	AD or WRITE delay  **RCD  **RCD  **RCD  **RCD  **RCD  **RP  **See corresponding speed bin tRP  **E command period  **RAS  **See corresponding speed bin tRAS  **Ommand period  **RC  **RRD  **MIN = greater of MIN = greater of ACK or 7.5ns  **ACK or 7.5ns  **TRAW  **See corresponding speed bin tRAS  **MIN = greater of MIN = greater of ACK or 7.5ns  **ACK or 7.5ns  **ACK or 7.5ns  **ACK or 7.5ns  **ACK or 7.5ns  **MIN = greater of ACK or 7.5ns  **N/A  **MIN = GREAD MIN = ACK; MAX = NA  **MOD  **MIN = GREAD MIN = ACK; MAX = NA  **MOD  **MIN = GREAD MIN = ACK; MAX = NA  **MOD  **MIN = ACK; MAX = NA  **MIN = ACK; MAX = NA  **MOD  **MOD	AD or WRITE delay  **RCD  See corresponding speed bin table for 'RCD  **RCD  **RP  See corresponding speed bin table for 'RP  E command period  **RAS  See corresponding speed bin table for 'RAS  command period  **RC  See corresponding speed bin table for 'RAS  command period  **RC  See corresponding speed bin table for 'RAS  **MRD  MIN = greater of ACK or 7.5ns   MIN = greater of ACK or 6ns    **TAW  **MRD  **TAW  **MRD  **MR	AD or WRITE delay  TRCD  See corresponding speed bin table for rRCD  TRP  See corresponding speed bin table for rRP  E command period  TRAS  See corresponding speed bin table for rRAS  MIN = greater of rRC  MIN = GREAD FRC  MIN = GREAD FRC



#### **Table 11: Electrical Characteristics and AC Operating Conditions for Speed Extensions (Continued)**

			gDDR:	3-2000	gDDR:	3-2200		
Parameter		Symbol	Min	Max	Min	Max	Unit	Notes
ZQCS command: Short c	alibration time	<sup>t</sup> ZQCS	64	-	64	_	CK	
	Initialization	and Reset Ti	ming					
Exit reset from CKE HIGI	H to a valid command	<sup>t</sup> XPR	MIN = greater of 5CK or ${}^{t}$ RFC + 10ns; MAX = N/A			CK		
Begin power supply ram stable	p to power supplies	<sup>t</sup> VDDPR	N	IIN = N/A;	MAX = 20	00	ms	
RESET# LOW to power s	upplies stable	<sup>t</sup> RPS	RPS MIN = 0; MAX = 200				ms	
RESET# LOW to I/O and	R <sub>TT</sub> High-Z	<sup>t</sup> IOZ	1	MIN = N/A	; MAX = 2	0	ns	35
	Refre	sh Timing						
EFRESH-to-ACTIVATE or REFRESH tRFC MIN = 260; MAX = 70,200 mmand period					ns			
Maximum refresh	T <sub>C</sub> ≤ 85°C	_		64 (	(1X)		ms	36
period	T <sub>C</sub> > 85°C		32 (2X)				ms	36
Maximum average	T <sub>C</sub> ≤ 85°C	<sup>t</sup> REFI	7.8 (64ms/8192)				μs	36
periodic refresh	T <sub>C</sub> > 85°C		3.9 (32ms/8192)			μs	36	
	Self Re	fresh Timing						
Exit self refresh to commands not requiring a locked DLL		<sup>t</sup> XS	MIN = g	reater of 5 MAX		C + 10ns;	CK	
Exit self refresh to comn locked DLL	nands requiring a	<sup>t</sup> XSDLL	MIN =	<sup>t</sup> DLLK (N	IN); MAX = N/A		CK	28
Minimum CKE low pulse entry to self refresh exit		<sup>t</sup> CKESR	MIN = <sup>t</sup>	CKE (MIN)	+ CK; MA	X = N/A	CK	
Valid clocks after self redown entry	fresh entry or power-	<sup>t</sup> CKSRE	MIN = gr	eater of 5		s; MAX =	CK	
Valid clocks before self r power-down exit, or res	•	<sup>t</sup> CKSRX	MIN = gr	eater of 5		s; MAX =	CK	
	Power-I	Down Timing	1					
CKE MIN pulse width		<sup>t</sup> CKE (MIN)		of 3CK or 25ns	Greater o	of 3CK or ns	CK	
Command pass disable of	delay	<sup>t</sup> CPDED	1	= 2; = N/A		= 1; = N/A	CK	
Power-down entry to po	ower-down exit timing	<sup>t</sup> PD	MIN = t	CKE (MIN)	; MAX = 9	× <sup>t</sup> REFI	CK	
Begin power-down perion	od prior to CKE regis-	<sup>t</sup> ANPD		WL -	CKE (MIN); MAX = 9 × <sup>t</sup> REFI WL - 1CK		CK	
Power-down entry perion nous or asynchronous	od: ODT either synchro-	PDE		of <sup>t</sup> ANPD imand to 0			CK	
Power-down exit period: ODT either synchronous or asynchronous		PDX	<sup>t</sup> ANPD + <sup>t</sup> XPDLL			CK		
	Power-Down En	try Minimun	Timing					



#### **Table 11: Electrical Characteristics and AC Operating Conditions for Speed Extensions (Continued)**

Notes 1–8 apply to the er	itire table		gDDR	3-2000	gDDR:	3-2200		
Parameter		Symbol	Min	Max	Min	Max	Unit	Notes
ACTIVATE command to p	oower-down entry	<sup>t</sup> ACTPDEN		MIN = 2		MIN = 1	CK	
PRECHARGE/PRECHARGE	ALL command to	<sup>t</sup> PRPDEN		MIN = 2		MIN = 1	CK	
power-down entry								
REFRESH command to po	ower-down entry	<sup>t</sup> REFPDEN		MIN = 2		MIN = 1	CK	37
MRS command to power	r-down entry	<sup>t</sup> MRSPDEN		$MIN = {}^{t}M$	OD (MIN)		CK	
READ/READ with auto p	recharge command to	<sup>t</sup> RDPDEN	MIN = RL + 4 + 1				CK	
power-down entry	1							
WRITE command to power-down entry	BL8 (OTF, MRS) BC4OTF	tWRPDEN	MIN:	= WL + 4 +	· <sup>t</sup> WR/ <sup>t</sup> CK	(AVG)	CK	
	BC4MRS	tWRPDEN	MIN:	= WL + 2 +	· tWR/tCK	(AVG)	CK	
WRITE with auto pre- charge command to	BL8 (OTF, MRS) BC4OTF	tWRAPDEN	MIN = WL + 4 + WR + 1				CK	
power-down entry	BC4MRS	tWRAPDEN	MIN = WL + 2 + WR + 1				CK	
	Power-Do	wn Exit Timir	ng					
DLL on, any valid comma mands not requiring lock	<sup>t</sup> XP	MIN = greater of 3CK or 6ns; MAX = N/A				CK		
Precharge power-down mands requiring a locker		<sup>t</sup> XPDLL	MIN = greater of 10CK or 24ns; MAX = N/A				CK	28
	OD	T Timing						
R <sub>TT</sub> synchronous turn-on	delay	ODTL on		CWL +	AL - 2CK		CK	38
R <sub>TT</sub> synchronous turn-off	delay	ODTL off		CWL + A	AL - 2CK		CK	40
R <sub>TT</sub> turn-on from ODTL o	on reference	<sup>t</sup> AON	-195	195	-195	195	ps	23, 38
R <sub>TT</sub> turn-off from ODTL of	off reference	<sup>t</sup> AOF	0.3	0.7	0.3	0.7	CK	39, 40
Asynchronous R <sub>TT</sub> turn-o (power-down with DLL o	-	<sup>t</sup> AONPD		MIN = 2; [	MAX = 8.5		ns	38
Asynchronous R <sub>TT</sub> turn-o (power-down with DLL o	-	<sup>t</sup> AOFPD		MIN = 2; [	MAX = 8.5		ns	40
ODT HIGH time with WR	ITE command and BL8	ODTH8		MIN = 6; N	/IAX = N/A	١	CK	
ODT HIGH time without with WRITE command ar		ODTH4		MIN = 4; N	MAX = N/A	<b>\</b>	CK	
	Dynami	ic ODT Timing						
R <sub>TT,nom</sub> -to-R <sub>TT(WR)</sub> change	e skew	ODTLcnw		WL -	2CK		CK	
R <sub>TT(WR)</sub> -to-R <sub>TT,nom</sub> change	e skew - BC4	ODTLcnw4					CK	
R <sub>TT(WR)</sub> -to-R <sub>TT,nom</sub> change	e skew - BL8	ODTLcnw8		6CK + C	DDTLoff		CK	
R <sub>TT</sub> dynamic change skev	V	<sup>t</sup> ADC	0.3 0.7 0.3 0.7			0.7	CK	39
	Write Le	veling Timing	3					
First DQS, DQS# rising ed	st DQS, DQS# rising edge		40	_	40	_	CK	
DQS, DQS# delay		tWLDQSEN	25	_	25	_	CK	



#### **Table 11: Electrical Characteristics and AC Operating Conditions for Speed Extensions**

,			gDDR3	3-2000	gDDR:	3-2200		
Parameter		Symbol	Min	Max	Min	Max	Unit	Notes
Write leveling setup from ing to rising DQS, DQS# of	•	tWLS	140	-	140	-	ps	
Write leveling hold from crossing to rising CK, CK	3	tWLH	140	_	140	_	ps	
Write leveling output de	lay	tWLO	0	7.5	0	7.5	ns	
Write leveling output en	ror	<sup>t</sup> WLOE	0	2	0	2	ns	
			gDDR3-1600 gDDR3-1800		3-1800			
Parameter		Symbol	Min	Max	Min	Max	Unit	Notes
	Clo	ck Timing						
Clock period average:	$T_C = 0$ °C to 85°C	tCK (DLL_DIS)	8	7800	8	7800	ns	9, 42
DLL disable mode	T <sub>C</sub> = >85°C to 115°C		8	3900	8	3900	ns	42
Clock period average: DL	L enable mode	<sup>t</sup> CK (AVG)	See corre		speed bin			10, 11
				range a	CK allowed			
High pulse width average	e	<sup>t</sup> CH (AVG)	0.47	0.53	0.47	0.53	CK	12
Low pulse width average	?	<sup>t</sup> CL (AVG)	0.47	0.53	0.47	0.53	CK	12
Clock period jitter	DLL locked	<sup>t</sup> JIT <sub>PER</sub>	-80	80	-70	70	ps	13
	DLL locking	<sup>t</sup> JIT <sub>PER</sub> ,lck	-70	70	-60	60	ps	13
Clock absolute period		tCK (ABS)			MIN + <sup>t</sup> JIT <sub>I</sub> TIL <sup>t</sup> + XAM		ps	
Clock absolute high pulse	e width	<sup>t</sup> CH (ABS)	0.43	_	0.43	_	<sup>t</sup> CK (AVG)	14
Clock absolute low pulse	width	<sup>t</sup> CL (ABS)	0.43	_	0.43	-	<sup>t</sup> CK (AVG)	15
Cycle-to-cycle jitter	DLL locked	<sup>t</sup> JIT <sub>CC</sub>	16	50	140		ps	16
	DLL locking	<sup>t</sup> JIT <sub>CC</sub> ,lck	14	40	1:	20	ps	16



#### **Table 11: Electrical Characteristics and AC Operating Conditions for Speed Extensions (Continued)**

Notes 1–8 apply to the en			gDDR3	3-1600	gDDR	3-1800		
Parameter		Symbol	Min	Max	Min	Max	Unit	Notes
Cumulative error across	2 cycles	Symbol   Min   Max   Min   Max     terraper   -118   118   -103   103     terraper   -140   140   -122   122     terraper   -155   155   -136   136     terraper   -168   168   -147   147     terraper   -168   168   -147   147     terraper   -177   177   -155   155     terraper   -186   186   -163   163     terraper   -186   186   -163   163     terraper   -193   193   -169   169     terraper   -200   200   -175   175     terraper   -205   205   -180   180     terraper   -210   210   -184   184     terraper   terraper   MIN   (1 + 0.68in[n]) × terraper     terraper   terraper   MAX = (1 + 0.68in[n]) × terraper     terraper   terraper   MAX = (1 + 0.68in[n]) × terraper     terraper   terraper   MAX = (1 + 0.68in[n]) × terraper     terraper   terraper   MAX = (1 + 0.68in[n]) × terraper     terraper   terraper   MAX = (1 + 0.68in[n]) × terraper     terraper   terraper   MAX = (1 + 0.68in[n]) × terraper     terraper   terraper   MAX = (1 + 0.68in[n]) × terraper     terraper   terraper   MAX = (1 + 0.68in[n]) × terraper     terraper   terraper   MAX = (1 + 0.68in[n]) × terraper     terraper   terraper   MAX = (1 + 0.68in[n]) × terraper     terraper   terraper   MAX = (1 + 0.68in[n]) × terraper     terraper   terraper   MAX = (1 + 0.68in[n]) × terraper     terraper   terraper   MAX = (1 + 0.68in[n]) × terraper     terraper   terraper   MAX = (1 + 0.68in[n]) × terraper     terraper   terraper   MAX = (1 + 0.68in[n]) × terraper     terraper   terraper   MAX = (1 + 0.68in[n]) × terraper     terraper   terraper   MAX = (1 + 0.68in[n]) × terraper     terraper   terraper   MAX = (1 + 0.68in[n]) × terraper     terraper   terraper   terraper   terraper     terraper   terraper   terraper   terraper   terraper     terraper   terraper   terraper   terraper   terraper   terraper   terraper     terraper   terrape	ps	17				
	3 cycles		-140	140	-122	122	ps	17
	4 cycles		-155	155	-136	136	ps	17
	5 cycles	tERR5 <sub>PER</sub>	-168	168	-147	147	ps	17
	6 cycles	tERR6 <sub>PER</sub>	-177	177	-155	155	ps	17
	7 cycles	tERR7 <sub>PER</sub>	-186	186	-163	163	ps	17
	8 cycles	tERR8 <sub>PER</sub>	-193	193	-169	169	ps	17
	9 cycles	tERR9 <sub>PER</sub>	-200	200	-175	175	ps	17
	10 cycles	tERR10 <sub>PER</sub>	-205	205	-180	180	ps	17
	11 cycles	tERR11 <sub>PER</sub>	-210	210	-184	184	ps	17
	12 cycles	tERR12 <sub>PER</sub>	-215	215	-188	188	ps	17
	<i>n</i> = 13, 1449, 50	<sup>t</sup> ERR <i>n</i> per	tERRn <sub>PER</sub>	MIN = (1 -	+ 0.68in[ <i>n</i> ]	) × <sup>t</sup> JIT <sub>PER</sub>	ps	17
	cycles		+					
	DO In	nut Timina		JI PE	RIVIAA			
Data setup time to DQS,	Base (specification)		_	_	T _	_	ps	18, 19
DQS#	V <sub>REF</sub> @ 1 V/ns			_			ps	19, 20
Data setup time to DQS,	Base (specification)		30	_	10		ps	18, 19
DQS#	V <sub>REF</sub> @ 1 V/ns						ps	19, 20
Data setup time to DQS,	Base (specification)@	<sup>t</sup> DS					ps	19, 20
DQS#	2 V/ns						Po	.5, _5
	V <sub>REF</sub> @ 2 V/ns		_	_	_	_		19, 20
Data hold time from	Base (specification)	<sup>t</sup> DH	65	_	45	_	ps	18, 19
DQS, DQS#	V <sub>REF</sub> @ 1 V/ns	(DC100)	165	-	145	_	ps	19, 20
Minimum data pulse wid	th	<sup>t</sup> DIPW	400	-	360	_	ps	41
	DQ Ou	tput Timing	•		1			
DQS, DQS# to DQ skew, p	per access	<sup>t</sup> DQSQ	_	125	_	100	ps	
DQ output hold time from	m DQS, DQS#	<sup>t</sup> QH	0.38	-	0.38	-	<sup>t</sup> CK (AVG)	21
DQ Low-Z time from CK,	CK#	tLZ (DQ)	-500	250	-450	225	ps	22, 23
DQ High-Z time from CK,	CK#	tHZ (DQ)	_	250	_			22, 23
	DQ Strob	e Input Timir	ng					
DQS, DQS# rising to CK, (	CK# rising	<sup>t</sup> DQSS	-0.25	0.25	-0.27	0.27	CK	25
DQS, DQS# differential in	nput low pulse width	<sup>t</sup> DQSL	0.45	0.55	0.45	0.55	CK	
DQS, DQS# differential in	nput high pulse width	<sup>t</sup> DQSH	0.45	0.55	0.45	0.55	CK	
DQS, DQS# falling setup	to CK, CK# rising	<sup>t</sup> DSS	0.2	_	0.18	_	CK	25



#### **Table 11: Electrical Characteristics and AC Operating Conditions for Speed Extensions (Continued)**

Notes 1–8 apply to the er	itire table		gDDR	3-1600	gDDR	3-1800		
Parameter		Symbol	Min	Max	Min	Max	Unit	Notes
DQS, DQS# falling hold f	rom CK, CK# rising	<sup>t</sup> DSH	0.2	_	0.18	_	CK	25
DQS, DQS# differential V	VRITE preamble	tWPRE	0.9	_	0.9	_	CK	
DQS, DQS# differential V	VRITE postamble	tWPST	0.3	_	0.3	_	CK	
	DQ Strobe	Output Timi	ng			1		
DQS, DQS# rising to/from	rising CK, CK#	<sup>t</sup> DQSCK	-255	255	-225	225	ps	23
DQS, DQS# rising to/from	rising CK, CK# when	<sup>t</sup> DQSCK	1	10	1	10	ns	26
DLL is disabled		(DLL_DIS)	0.40		0.40		- CI	24
DQS, DQS# differential o	<u> </u>	<sup>t</sup> QSH	0.40	_	0.40	_	CK	21
DQS, DQS# differential o	•	<sup>t</sup> QSL	0.40	_	0.40	-	CK	21
DQS, DQS# Low-Z time (F		tLZ (DQS)	-500	250	<del>-450</del>	225	ps	22, 23
DQS, DQS# High-Z time (		tHZ (DQS)	-	250	_	225	ps	22, 23
DQS, DQS# differential R	EAD preamble	<sup>t</sup> RPRE	0.9	Note 24	0.9	Note 24	CK	23, 24
DQS, DQS# differential R	EAD postamble	<sup>t</sup> RPST	0.3	Note 27	0.3	Note 27	CK	23, 27
	Command and Address Timing							
DLL locking time		<sup>t</sup> DLLK	512	_	512	_	CK	28
CTRL, CMD, ADDR	Base (specification)	<sup>t</sup> IS	65	_	45	_	ps	29, 30
setup to CK,CK#	V <sub>REF</sub> @ 1 V/ns	(AC175)	240	_	220	_	ps	20, 30
CTRL, CMD, ADDR	Base (specification)	<sup>t</sup> IS	190	_	170	_	ps	29, 30
setup to CK,CK#	V <sub>REF</sub> @ 1 V/ns	(AC150)	340	_	320	_	ps	20, 30
CTRL, CMD, ADDR	Base (specification)	<sup>t</sup> IS	_	_	_	_	ps	
setup to CK,CK#	V <sub>REF</sub> @ 1 V/ns	(AC135)	_	_	_	_	ps	
CTRL, CMD, ADDR	Base (specification)	<sup>t</sup> IS	_	_	_	_	ps	
setup to CK,CK#	V <sub>REF</sub> @ 1 V/ns	(AC125)	_	_	_	_	ps	
CTRL, CMD, ADDR hold	Base (specification)	<sup>t</sup> IH	140	_	120	_	ps	29, 30
from CK,CK#	V <sub>REF</sub> @ 1 V/ns	(DC100)	240	_	220	_	ps	20, 30
Minimum CTRL, CMD, AI	DDR pulse width	<sup>t</sup> IPW	620	_	560	_	ps	41
ACTIVATE to internal REA	AD or WRITE delay	<sup>t</sup> RCD	See corre	esponding tRO		table for	ns	31
PRECHARGE command p	eriod	<sup>t</sup> RP	See corre	esponding t <sub>R</sub>	-	table for	ns	31
ACTIVATE-to-PRECHARG	E command period	<sup>t</sup> RAS	See corre	esponding t <sub>R</sub> ,	-	table for	ns	31, 32
ACTIVATE-to-ACTIVATE of	ommand period	<sup>t</sup> RC	tRAS  See corresponding speed bin table for tRC				ns	31
ACTIVATE-to-ACTIVATE minimum command peri	od	<sup>t</sup> RRD	_	reater of r 7.5ns	_	reater of r 7.5ns	CK	31
Four ACTIVATE windows		<sup>t</sup> FAW	45	_	40	_	ns	31



#### **Table 11: Electrical Characteristics and AC Operating Conditions for Speed Extensions (Continued)**

			gDDR	3-1600	gDDR	3-1800		
Parameter		Symbol	Min	Max	Min	Max	Unit	Notes
Write recovery time		<sup>t</sup> WR	15	N/A	15	N/A	ns	31, 32, 33
Delay from start of interi to internal READ comma		tWTR	MIN = gr	MIN = greater of 4CK or 7.5ns; MAX = N/A				31, 34
READ-to-PRECHARGE tim	ne	tRTP	MIN = gr	eater of 4 N	CK or 7.5r /A	ns; MAX =	CK	31, 32
CAS#-to-CAS# command	delay	<sup>t</sup> CCD	N	/IN = 4CK;	MAX = N	/A	CK	
Auto precharge write rec time	<sup>t</sup> DAL	MIN = W	R + <sup>t</sup> RP/ <sup>t</sup> Cl	( (AVG); M	1AX = N/A	CK		
MODE REGISTER SET com	<sup>t</sup> MRD	N	/IN = 4CK;	MAX = N	/A	CK		
MODE REGISTER SET com	nmand update delay	tMOD	MIN = gr	MIN = greater of 12CK or 15ns; MAX = N/A				
MULTIPURPOSE REGISTER mode register set for mu		<sup>t</sup> MPRR	N	/IIN = 1CK;	MAX = N	/A	CK	
	Calibra	ation Timing						
ZQCL command: Long calibration time	POWER-UP and RE- SET operation	<sup>t</sup> ZQ <sub>INIT</sub>	512	_	512	-	CK	
	Normal operation	<sup>t</sup> ZQ <sub>OPER</sub>	256	_	256	_	CK	
ZQCS command: Short ca	libration time	<sup>t</sup> ZQCS	64	_	64	64 –		
	Initialization	and Reset T	iming					
Exit reset from CKE HIGH	to a valid command	<sup>t</sup> XPR	MIN = g		er of 5CK or <sup>t</sup> RFC + 10ns; MAX = N/A			
Begin power supply ramp stable	o to power supplies	tVDDPR	N	/IN = N/A;	MAX = 20	00	ms	
RESET# LOW to power su	ipplies stable	tRPS		MIN = 0; [	MAX = 200	)	ms	
RESET# LOW to I/O and R	R <sub>TT</sub> High-Z	<sup>t</sup> IOZ	I	MIN = N/A	; MAX = 2	0	ns	35
	Refr	esh Timing						
REFRESH-to-ACTIVATE or command period	REFRESH	<sup>t</sup> RFC	MI	N = 260; N	ЛАX = 70,.	200	ns	
Maximum refresh	T <sub>C</sub> ≤ 85°C	_		64	(1X)		ms	36
period	T <sub>C</sub> > 85°C			32	(2X)		ms	36
Maximum average	T <sub>C</sub> ≤ 85°C	<sup>t</sup> REFI		7.8 (64r	ms/8192)		μs	36
periodic refresh	T <sub>C</sub> > 85°C	3.9 (32ms/8192)					μs	36
	Self Re	fresh Timing						
Exit self refresh to commands not requiring a locked DLL		<sup>t</sup> XS	MIN = greater of 5CK or ${}^{t}RFC + 10ns$ ; MAX = N/A			C + 10ns;	CK	
Exit self refresh to comm locked DLL	mands requiring a ${}^{t}XSDLL$ $MIN = {}^{t}DLLK (MIN); MAX = N/A$					CK	28	



#### **Table 11: Electrical Characteristics and AC Operating Conditions for Speed Extensions (Continued)**

Notes 1–8 apply to the e	Titile table		gDDR	3-1600	gDDR3	3-1800		
Parameter		Symbol	Min	Max	Min	Max	Unit	Notes
Minimum CKE low pulse entry to self refresh exit		<sup>t</sup> CKESR	MIN =	CKE (MIN)	+ CK; MA	X = N/A	CK	
Valid clocks after self re down entry	fresh entry or power-	<sup>t</sup> CKSRE	MIN = g	reater of 5 N	CK or 10ns	s; MAX =	CK	
Valid clocks before self i power-down exit, or res	•	<sup>t</sup> CKSRX	MIN = g	reater of 5 N	CK or 10ns /A	s; MAX =	CK	
	Power-l	Down Timing						
CKE MIN pulse width		<sup>t</sup> CKE (MIN)		of 3CK or 25ns	Greater of		CK	
Command pass disable of	delay	<sup>t</sup> CPDED			MIN = 1; MAX = N/A MIN); MAX = 9 × <sup>t</sup> REFI		CK	
Power-down entry to po	ower-down exit timing	<sup>t</sup> PD	MIN =	tCKE (MIN)	× <sup>t</sup> REFI	CK		
Begin power-down peri tered HIGH	od prior to CKE regis-	<sup>t</sup> ANPD		WL -	1CK		CK	
Power-down entry perion nous or asynchronous	od: ODT either synchro-	PDE	Greater of <sup>t</sup> ANPD or <sup>t</sup> RFC - REFRESH command to CKE LOW time				CK	
Power-down exit period synchronous or asynchro		PDX	<sup>t</sup> ANPD + <sup>t</sup> XPDLL				CK	
	Power-Down Er	ntry Minimun	Timing					
ACTIVATE command to	power-down entry	<sup>t</sup> ACTPDEN		MIN	I = 1		CK	
PRECHARGE/PRECHARG power-down entry	E ALL command to	<sup>t</sup> PRPDEN	MIN = 1			CK		
REFRESH command to p	ower-down entry	<sup>t</sup> REFPDEN		MIN	I = 1		CK	37
MRS command to powe	r-down entry	<sup>t</sup> MRSPDEN		MIN = <sup>t</sup> M	OD (MIN)		CK	
READ/READ with auto p power-down entry	recharge command to	<sup>t</sup> RDPDEN		MIN = R	L + 4 + 1		CK	
WRITE command to power-down entry	BL8 (OTF, MRS) BC4OTF	<sup>t</sup> WRPDEN	MIN	= WL + 4 +	· <sup>t</sup> WR/ <sup>t</sup> CK (	AVG)	CK	
	BC4MRS	tWRPDEN	MIN	= WL + 2 +	· tWR/tCK (	AVG)	CK	
WRITE with auto pre- charge command to	BL8 (OTF, MRS) BC4OTF	<sup>t</sup> WRAPDEN	N	/IN = WL +	4 + WR +	1	CK	
power-down entry	BC4MRS	tWRAPDEN	N	/IN = WL +	2 + WR +	1	CK	
	Power-Do	wn Exit Timi	ng					
DLL on, any valid comm mands not requiring loc	•	<sup>t</sup> XP	MIN = g	MIN = greater of 3CK or 6ns; MAX = N/A		; MAX =	CK	
Precharge power-down mands requiring a locke	<sup>t</sup> XPDLL	MIN = greater of 10CK or 24ns; MAX = N/A		CK	28			
	OD	T Timing	·					
R <sub>TT</sub> synchronous turn-or	n delay	ODTL on		CWL +	AL - 2CK		CK	38
			_					_



#### Table 11: Electrical Characteristics and AC Operating Conditions for Speed Extensions (Continued)

Notes 1–6 apply to the entire table		gDDR:	3-1600	gDDR:	3-1800		
Parameter	Symbol	Min	Max	Min	Max	Unit	Notes
R <sub>TT</sub> synchronous turn-off delay	ODTL off		CWL + /	AL - 2CK		CK	40
R <sub>TT</sub> turn-on from ODTL on reference	<sup>t</sup> AON	-250	250	-225	225	ps	23, 38
R <sub>TT</sub> turn-off from ODTL off reference	<sup>t</sup> AOF	0.3	0.7	0.3	0.7	CK	39, 40
Asynchronous R <sub>TT</sub> turn-on delay (power-down with DLL off)	<sup>t</sup> AONPD		MIN = 2; I	MAX = 8.5		ns	38
Asynchronous R <sub>TT</sub> turn-off delay (power-down with DLL off)	<sup>t</sup> AOFPD		MIN = 2; I	MAX = 8.5		ns	40
ODT HIGH time with WRITE command and BL8	ODTH8		MIN = 6; N	MAX = N/A		CK	
ODT HIGH time without WRITE command or with WRITE command and BC4	ODTH4	MIN = 4; MAX = N/A		CK			
Dynami	c ODT Timing						
R <sub>TT,nom</sub> -to-R <sub>TT(WR)</sub> change skew	ODTLcnw		WL -	· 2CK		CK	
R <sub>TT(WR)</sub> -to-R <sub>TT,nom</sub> change skew - BC4	ODTLcnw4		4CK + 0	DDTLoff		CK	
R <sub>TT(WR)</sub> -to-R <sub>TT,nom</sub> change skew - BL8	ODTLcnw8		6CK + 0	DDTLoff		CK	
R <sub>TT</sub> dynamic change skew	<sup>t</sup> ADC	0.3	0.7	0.3	0.7	CK	39
Write Le	veling Timing	l					
First DQS, DQS# rising edge	tWLMRD	40	_	40	-	CK	
DQS, DQS# delay	tWLDQSEN	25	_	25	-	CK	
Write leveling setup from rising CK, CK# crossing to rising DQS, DQS# crossing	tWLS	195	_	165	_	ps	
Write leveling hold from rising DQS, DQS# crossing to rising CK, CK# crossing	<sup>t</sup> WLH	195	_	165	_	ps	
Write leveling output delay	tWLO	0	9	0	7.5	ns	
Write leveling output error	tWLOE	0	2	0	2	ns	

- Notes: 1. Parameters are applicable with  $0^{\circ}\text{C} \le T_{\text{C}} \le 115^{\circ}\text{C}$  and  $V_{\text{DD}}/V_{\text{DDO}} = 1.5\text{V} \pm 0.075\text{V}$ .
  - 2. All voltages are referenced to V<sub>SS</sub>.
  - 3. Output timings are only valid for  $R_{ON34}$  output buffer selection.
  - 4. The unit <sup>t</sup>CK (AVG) represents the actual <sup>t</sup>CK (AVG) of the input clock under operation. The unit CK represents one clock cycle of the input clock, counting the actual clock
  - 5. AC timing and I<sub>DD</sub> tests may use a V<sub>II</sub>-to-V<sub>IH</sub> swing of up to 900mV in the test environment, but input timing is still referenced to V<sub>RFF</sub> (except <sup>t</sup>IS, <sup>t</sup>IH, <sup>t</sup>DS, and <sup>t</sup>DH use the AC/DC trip points, and CK, CK# and DQS, DQS# use their crossing points). The minimum slew rate for the input signals used to test the device is 1 V/ns for single-ended inputs and 2 V/ns for differential inputs in the range between  $V_{IL(AC)}$  and  $V_{IH(AC)}$ .
  - 6. All timings that use time-based values (ns, µs, ms) should use <sup>t</sup>CK (AVG) to determine the correct number of clocks (this table uses CK or <sup>t</sup>CK [AVG] interchangeably). In the case of noninteger results, all minimum limits are to be rounded up to the nearest whole integer, and all maximum limits are to be rounded down to the nearest whole integer.



- 7. Strobe or DQS diff refers to the DQS and DQS# differential crossing point when DQS is the rising edge. Clock or CK refers to the CK and CK# differential crossing point when CK is the rising edge.
- 8. This output load is used for all AC timing (except ODT reference timing) and slew rates. The actual test load may be different. The output signal voltage reference point is V<sub>DDO</sub>/2 for single-ended signals and the crossing point for differential signals.
- 9. When operating in DLL disable mode, Micron does not warrant compliance with normal mode timings or functionality.
- 10. The clock's <sup>t</sup>CK (AVG) is the average clock over any 200 consecutive clocks and <sup>t</sup>CK (AVG) MIN is the smallest clock rate allowed, with the exception of a deviation due to clock jitter. Input clock jitter is allowed provided it does not exceed values specified and must be of a random Gaussian distribution in nature.
- 11. Spread spectrum is not included in the jitter specification values. However, the input clock can accommodate spread-spectrum at a sweep rate in the range of 20–60 kHz with an additional 1% of <sup>t</sup>CK (AVG) as a long-term jitter component; however, the spread spectrum may not use a clock rate below <sup>t</sup>CK (AVG) MIN.
- 12. The clock's <sup>t</sup>CH (AVG) and <sup>t</sup>CL (AVG) are the average half clock period over any 200 consecutive clocks and is the smallest clock half period allowed, with the exception of a deviation due to clock jitter. Input clock jitter is allowed provided it does not exceed values specified and must be of a random Gaussian distribution in nature.
- 13. The period jitter (<sup>t</sup>JIT<sub>PER</sub>) is the maximum deviation in the clock period from the average or nominal clock. It is allowed in either the positive or negative direction.
- 14. <sup>t</sup>CH (ABS) is the absolute instantaneous clock high pulse width as measured from one rising edge to the following falling edge.
- 15. <sup>t</sup>CL (ABS) is the absolute instantaneous clock low pulse width as measured from one falling edge to the following rising edge.
- 16. The cycle-to-cycle jitter <sup>t</sup>JIT<sub>CC</sub> is the amount the clock period can deviate from one cycle to the next. It is important to keep cycle-to-cycle jitter at a minimum during the DLL locking time.
- 17. The cumulative jitter error  ${}^{t}$ ERRnPER, where n is the number of clocks between 2 and 50, is the amount of clock time allowed to accumulate consecutively away from the average clock over n number of clock cycles.
- 18. <sup>t</sup>DS (base) and <sup>t</sup>DH (base) values are for a single-ended 1 V/ns DQ slew rate and 2 V/ns differential DQS, DQS# slew rate.
- 19. These parameters are measured from a data signal (DM, DQ0, DQ1, and so forth) transition edge to its respective data strobe signal (DQS, DQS#) crossing.
- 20. The setup and hold times are listed converting the base specification values (to which derating tables apply) to  $V_{REF}$  when the slew rate is 1 V/ns. These values, with a slew rate of 1 V/ns, are for reference only.
- 21. When the device is operated with input clock jitter, this parameter needs to be derated by the actual <sup>t</sup>JIT<sub>PER</sub> (larger of <sup>t</sup>JIT<sub>PER</sub> (MIN) or <sup>t</sup>JIT<sub>PER</sub> (MAX) of the input clock (output deratings are relative to the SDRAM input clock).
- 22. Single-ended signal parameter.
- 23. The DRAM output timing is aligned to the nominal or average clock. Most output parameters must be derated by the actual jitter error when input clock jitter is present, even when within specification. This results in each parameter becoming larger. The following parameters are required to be derated by subtracting <sup>t</sup>ERR<sub>10PER</sub> (MAX): <sup>t</sup>DQSCK (MIN), <sup>t</sup>LZ(DQS) MIN, <sup>t</sup>LZ(DQ) MIN, and <sup>t</sup>AON (MIN). The following parameters are required to be derated by subtracting <sup>t</sup>ERR<sub>10PER</sub> (MIN): <sup>t</sup>DQSCK (MAX), <sup>t</sup>HZ (MAX), <sup>t</sup>LZ (DQS) MAX, <sup>t</sup>LZ (DQ) MAX, and <sup>t</sup>AON (MAX). The parameter <sup>t</sup>RPRE (MIN) is derated by subtracting <sup>t</sup>JIT<sub>PER</sub> (MAX), while <sup>t</sup>RPRE (MAX) is derated by subtracting <sup>t</sup>JIT<sub>PER</sub> (MIN).
- 24. The maximum preamble is bound by <sup>t</sup>LZDQS (MAX).
- 25. These parameters are measured from a data strobe signal (DQS, DQS#) crossing to its respective clock signal (CK, CK#) crossing. The specification values are not affected by the



- amount of clock jitter applied because these are relative to the clock signal crossing. These parameters should be met whether clock jitter is present.
- 26. The <sup>t</sup>DQSCK (DLL\_DIS) parameter begins CL + AL 1 cycles after the READ command.
- 27. The maximum postamble is bound by <sup>t</sup>HZDQS (MAX).
- 28. Commands requiring a locked DLL are READ (and RDAP) and synchronous ODT commands. In addition, after any change of latency <sup>t</sup>XPDLL, timing must be met.
- 29. <sup>t</sup>IS (base) and <sup>t</sup>IH (base) values are for a single-ended 1 V/ns control/command/address slew rate and 2 V/ns CK, CK# differential slew rate.
- 30. These parameters are measured from a command/address signal transition edge to its respective clock (CK, CK#) signal crossing. The specification values are not affected by the amount of clock jitter applied as the setup and hold times are relative to the clock signal crossing that latches the command/address. These parameters should be met whether clock jitter is present.
- 31. For these parameters, the DDR3 SDRAM device supports <sup>†</sup>nPARAM (nCK) = RU(<sup>†</sup>PARAM [ns]/<sup>†</sup>CK[AVG] [ns]), assuming all input clock jitter specifications are satisfied. For example, the device will support <sup>†</sup>nRP (nCK) = RU(<sup>†</sup>RP/<sup>†</sup>CK[AVG]) if all input clock jitter specifications are met. This means that for DDR3-800 6-6-6, of which <sup>†</sup>RP = 15ns, the device will support <sup>†</sup>nRP = RU(<sup>†</sup>RP/<sup>†</sup>CK[AVG]) = 6 as long as the input clock jitter specifications are met. That is, the PRECHARGE command at T0 and the ACTIVATE command at T0 + 6 are valid even if six clocks are less than 15ns due to input clock jitter.
- 32. During READs and WRITEs with auto precharge, the DDR3 SDRAM will hold off the internal PRECHARGE command until <sup>t</sup>RAS (MIN) has been satisfied.
- 33. When operating in DLL disable mode, the greater of 4CK or 15ns is satisfied for <sup>t</sup>WR.
- 34. The start of the write recovery time is defined as follows:
  - For BL8 (fixed by MRS and OTF): Rising clock edge four clock cycles after WL
  - For BC4 (OTF): Rising clock edge four clock cycles after WL
  - For BC4 (fixed by MRS): Rising clock edge two clock cycles after WL
- 35. RESET# should be LOW as soon as power starts to ramp to ensure the outputs are in High-Z. Until RESET# is LOW, the outputs are at risk of driving and could result in excessive current, depending on bus activity.
- 36. The refresh period is 64ms when  $T_C$  is less than or equal to 85°C. This equates to an average refresh rate of 7.8125 $\mu$ s. However, nine REFRESH commands should be asserted at least once every 70.3 $\mu$ s. When  $T_C$  is greater than 85°C, the refresh period is 32ms.
- 37. Although CKE is allowed to be registered LOW after a REFRESH command when <sup>t</sup>REFPDEN (MIN) is satisfied, there are cases where additional time such as <sup>t</sup>XPDLL (MIN) is required.
- 38. ODT turn-on time MIN is when the device leaves High-Z and ODT resistance begins to turn on. ODT turn-on time maximum is when the ODT resistance is fully on.
- 39. Half-clock output parameters must be derated by the actual <sup>t</sup>ERR<sub>10PER</sub> and <sup>t</sup>JIT<sub>DTY</sub> when input clock jitter is present. This results in each parameter becoming larger. The parameters <sup>t</sup>ADC (MIN) and <sup>t</sup>AOF (MIN) are each required to be derated by subtracting both <sup>t</sup>ERR<sub>10PER</sub> (MAX) and <sup>t</sup>JIT<sub>DTY</sub> (MAX). The parameters <sup>t</sup>ADC (MAX) and <sup>t</sup>AOF (MAX) are required to be derated by subtracting both <sup>t</sup>ERR<sub>10PER</sub> (MAX) and <sup>t</sup>JIT<sub>DTY</sub> (MAX).
- 40. ODT turn-off time minimum is when the device starts to turn off ODT resistance. ODT turn-off time maximum is when the DRAM buffer is in High-Z.
- 41. Pulse width of an input signal is defined as the width between the first crossing of V<sub>REF(DC)</sub>.
- 42. Should the clock rate be larger than <sup>t</sup>RFC (MIN), an AUTO REFRESH command should have at least one NOP command between it and another AUTO REFRESH command. Additionally, if the clock rate is slower than 40ns (25 MHz), all REFRESH commands should be followed by an AUTO PRECHARGE command.

# 4Gb: x16 gDDR3 SDRAM Graphics Addendum Command and Address Setup, Hold, and Derating

# **Command and Address Setup, Hold, and Derating**

The total <sup>t</sup>IS (setup time) and <sup>t</sup>IH (hold time) required is calculated by adding the data sheet <sup>t</sup>IS (base) and <sup>t</sup>IH (base) values to the  $\Delta^{t}$ IS and  $\Delta^{t}$ IH derating values, respectively. Example: <sup>t</sup>IS (total setup time) = <sup>t</sup>IS (base) +  $\Delta^{t}$ IS. For a valid transition, the input signal has to remain above/below  $V_{IH(AC)}/V_{IL(AC)}$  for some time <sup>t</sup>VAC.

Although the total setup time for slow slew rates might be negative (for example, a valid input signal will not have reached  $V_{IH(AC)}/V_{IL(AC)}$  at the time of the rising clock transition), a valid input signal is still required to complete the transition and to reach  $V_{IH(AC)}/V_{IL(AC)}$ .

Setup ( ${}^{t}$ IS) nominal slew rate for a rising signal is defined as the slew rate between the last crossing of  $V_{REF(DC)}$  and the first crossing of  $V_{IH(AC)min}$ . Setup ( ${}^{t}$ IS) nominal slew rate for a falling signal is defined as the slew rate between the last crossing of  $V_{REF(DC)}$  and the first crossing of  $V_{IL(AC)max}$ . If the actual signal is always earlier than the nominal slew rate line between the shaded  $V_{REF(DC)}$ -to-AC region, use the nominal slew rate for derating value. If the actual signal is later than the nominal slew rate line anywhere between the shaded  $V_{REF(DC)}$ -to-AC region, the slew rate of a tangent line to the actual signal from the AC level to the DC level is used for derating value.

Hold ( ${}^{t}IH$ ) nominal slew rate for a rising signal is defined as the slew rate between the last crossing of  $V_{IL(DC)max}$  and the first crossing of  $V_{REF(DC)}$ . Hold ( ${}^{t}IH$ ) nominal slew rate for a falling signal is defined as the slew rate between the last crossing of  $V_{IH(DC)min}$  and the first crossing of  $V_{REF(DC)}$ . If the actual signal is always later than the nominal slew rate line between the shaded DC-to- $V_{REF(DC)}$  region, use the nominal slew rate for derating value. If the actual signal is earlier than the nominal slew rate line anywhere between the shaded DC-to- $V_{REF(DC)}$  region, the slew rate of a tangent line to the actual signal from the DC level to the  $V_{REF(DC)}$  level is used for derating value.

Table 12: Command and Address Setup and Hold Values Referenced at 1 V/ns - AC/DC-Based

Symbol	gDDR3-1600	gDDR3-1800	gDDR3-2000	gDDR3-2200	Unit	Reference
<sup>t</sup> IS (base) AC175	65	45	_	_	ps	V <sub>IH(AC)</sub> /V <sub>IL(AC)</sub>
<sup>t</sup> IS (base) AC150	190	170	_	_	ps	V <sub>IH(AC)</sub> /V <sub>IL(AC)</sub>
<sup>t</sup> IS (base) AC135	_	_	65	65	ps	V <sub>IH(AC)</sub> /V <sub>IL(AC)</sub>
<sup>t</sup> IS (base) AC125	_	_	150	150	ps	V <sub>IH(AC)</sub> /V <sub>IL(AC)</sub>
<sup>t</sup> IH (base) DC100	140	120	100	100	ps	V <sub>IH(DC)</sub> /V <sub>IL(DC)</sub>

# 4Gb: x16 gDDR3 SDRAM Graphics Addendum Data Setup, Hold, and Derating

### **Data Setup, Hold, and Derating**

The total <sup>t</sup>DS (setup time) and <sup>t</sup>DH (hold time) required is calculated by adding the data sheet <sup>t</sup>DS (base) and <sup>t</sup>DH (base) values to the  $\Delta^t$ DS and  $\Delta^t$ DH derating values, respectively. Example: <sup>t</sup>DS (total setup time) = <sup>t</sup>DS (base) +  $\Delta^t$ DS. For a valid transition, the input signal has to remain above/below  $V_{IH(AC)}/V_{II,(AC)}$  for some time <sup>t</sup>VAC.

Although the total setup time for slow slew rates might be negative (for example, a valid input signal will not have reached  $V_{IH(AC)}/V_{IL(AC)}$ ) at the time of the rising clock transition), a valid input signal is still required to complete the transition and to reach  $V_{IH}/V_{IL(AC)}$ .

Setup ( ${}^{t}DS$ ) nominal slew rate for a rising signal is defined as the slew rate between the last crossing of  $V_{REF(DC)}$  and the first crossing of  $V_{IH(AC)min}$ . Setup ( ${}^{t}DS$ ) nominal slew rate for a falling signal is defined as the slew rate between the last crossing of  $V_{REF(DC)}$  and the first crossing of  $V_{IL(AC)max}$ . If the actual signal is always earlier than the nominal slew rate line between the shaded  $V_{REF(DC)}$ -to-AC region, use the nominal slew rate for derating value. If the actual signal is later than the nominal slew rate line anywhere between the shaded  $V_{REF(DC)}$ -to-AC region, the slew rate of a tangent line to the actual signal from the AC level to the DC level is used for derating value.

Hold ( $^{t}DH$ ) nominal slew rate for a rising signal is defined as the slew rate between the last crossing of  $V_{IL(DC)max}$  and the first crossing of  $V_{REF(DC)}$ . Hold ( $^{t}DH$ ) nominal slew rate for a falling signal is defined as the slew rate between the last crossing of  $V_{IH(DC)min}$  and the first crossing of  $V_{REF(DC)}$ . If the actual signal is always later than the nominal slew rate line between the shaded DC-to- $V_{REF(DC)}$  region, use the nominal slew rate for derating value. If the actual signal is earlier than the nominal slew rate line anywhere between the shaded DC-to- $V_{REF(DC)}$  region, the slew rate of a tangent line to the actual signal from the DC-to- $V_{REF(DC)}$  region is used for derating value.

Table 13: Data Setup and Hold Values at 1 V/ns (DQS, DQS# at 2 V/ns) - AC/DC-Based

Symbol	gDDR3-1600	gDDR3-1800	gDDR3-2000	gDDR3-2200	Unit	Reference
<sup>t</sup> DS (base) AC175	_	_	_	_	ps	$V_{IH(AC)}/V_{IL(AC)}$
<sup>t</sup> DS (base) AC150	30	10	-	_	ps	$V_{IH(AC)}/V_{IL(AC)}$
<sup>t</sup> DS (base) AC135	60	40	68	68	ps	V <sub>IH(AC)</sub> /V <sub>IL(AC)</sub>
<sup>t</sup> DH (base) DC100	65	45	70	70	ps	$V_{IH(DC)}/V_{IL(DC)}$

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